

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10750502	HILL ET AL.
Examiner	Art Unit	
Nguyen, Jennifer T	2629	

SEARCHED

Class	Subclass	Date	Examiner
345	173-177,156,160,169	4/23/08	JN

SEARCH NOTES

Search Notes	Date	Examiner
east, PG-Pub, IEEE, PJO, US-PAT, EPO, DERWENT, Inventors, Claim interference	4/23/08	JN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
178	18.01-18.20	4/23/08	JN